Power MOSFET

-20 V, -4.9 A, P-Channel ChipFET™

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space
- Pb–Free Package is Available

Applications

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

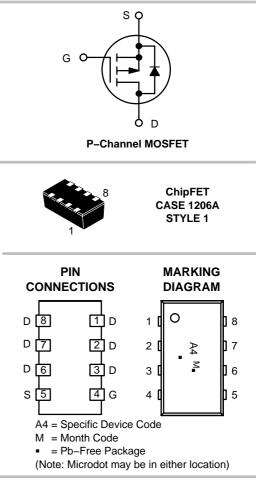
MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
–20 V	56 mΩ @ -4.5	-4.9 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTHS5443T1	ChipFET	3000/Tape & Reel
NTHS5443T1G	ChipFET (Pb–Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

V _{DS} V _{GS} I _D		20 12	V V
	±	12	V
I _D			
	-4.9 -3.5	-3.6 -2.6	A
I _{DM}	±	15	А
۱ _S	-4.9	-3.6	А
PD	2.5 1.3	1.3 0.7	W
T _J , T _{stg}	–55 to	9 +150	°C
r	I _{DM} Is P _D T _J , T _{stg}	$\begin{array}{c} -4.9 \\ -3.5 \\ \hline I_{DM} & \pm \\ \hline I_S & -4.9 \\ \hline P_D & 2.5 \\ 1.3 \\ \hline T_J, T_{stg} & -55 tc \end{array}$	$\begin{array}{c c} -4.9 \\ -3.5 \\ \hline \\ I_{DM} \\ 1_{S} \\ I_{S} \\ P_{D} \\ 2.5 \\ 1.3 \\ 0.7 \\ \hline \end{array} \begin{array}{c} -3.6 \\$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 2) t \leq 5 s Steady State	R _{θJA}	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R_{\thetaJF}	15	20	°C/W

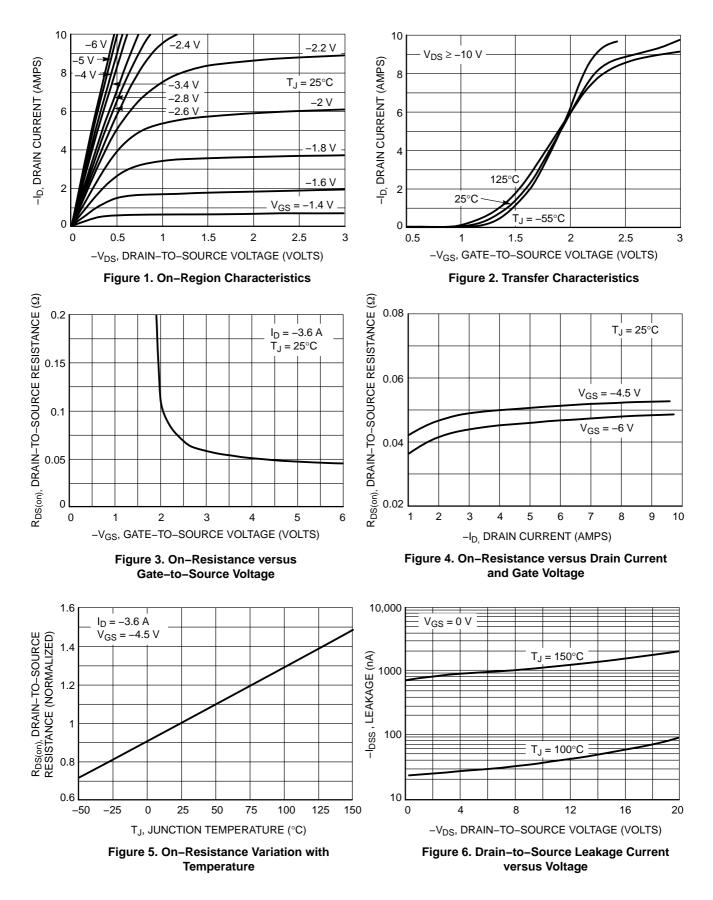
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

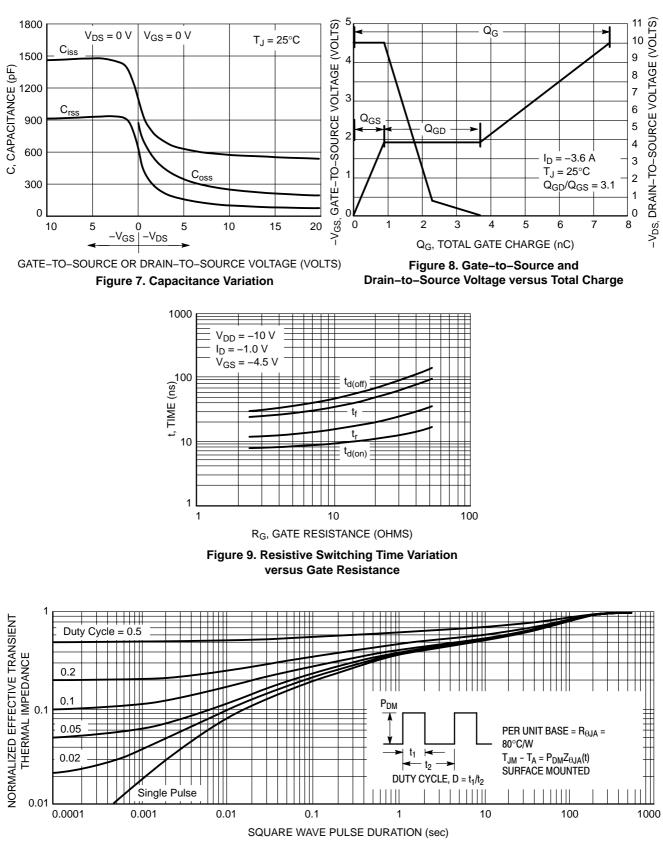
Characteristic	Symbol	ymbol Test Condition		Тур	Мах	Unit	
Static							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.6			V	
Gate-Body Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = \pm 12 V			±100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1.0	μΑ	
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85^{\circ}\text{C}$			-5.0		
On-State Drain Current (Note 3)	I _{D(on)}	V_{DS} \leq –5.0 V, V_{GS} = –4.5 V	–15			А	
Drain–Source On–State Resistance (Note 3)	r _{DS(on)}	V_{GS} = -4.5 V, I_{D} = -3.6 A V_{GS} = -3.6 V, I_{D} = -3.3 A		0.056 0.065	0.065 0.074	Ω	
		V_{GS} = -2.5 V, I _D = -2.7 A		0.095	0.110	1	
Forward Transconductance (Note 3)	9 _{fs}	V _{DS} = -10 V, I _D = -3.6 A		10		S	
Diode Forward Voltage (Note 3)	V _{SD}	$I_{S} = -1.1 \text{ A}, V_{GS} = 0 \text{ V}$		-0.8	-1.2	V	
Dynamic (Note 4)	-	<u>.</u>	•	-	-	-	
Total Gate Charge	Q _G			7.5	12	nC	
		$V_{} = -10 V V_{} = -15 V$		1	1	-	

Total Gate Charge	Q _G		7.5	12	nC
Gate-Source Charge	Q _{GS}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -3.6 \text{ A}$	0.9	2.8	1
Gate-Drain Charge	Q _{GD}		2.2	-	
Turn-On Delay Time	t _{d(on)}		8.5	13	ns
Rise Time	tr	$V_{DD} = -10 \text{ V}, \text{ R}_{\text{L}} = 10 \Omega$ $I_{\text{D}} \cong -1.0 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V},$	14	21	
Turn-Off Delay Time	t _{d(off)}	$R_{\rm G} = 6 \ \Omega$	38	57	
Fall Time	t _f	1	30	45	1
Source–Drain Reverse Recovery Time	t _{rr}	I _F = -1.1 A, di/dt = 100 A/μs	30	60	ns

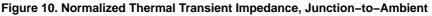
Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS



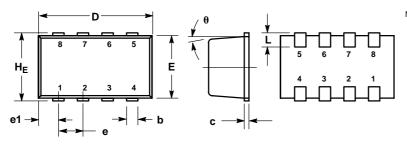


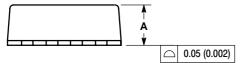
TYPICAL ELECTRICAL CHARACTERISTICS



PACKAGE DIMENSIONS

ChipFET™ CASE 1206A-03 ISSUE G





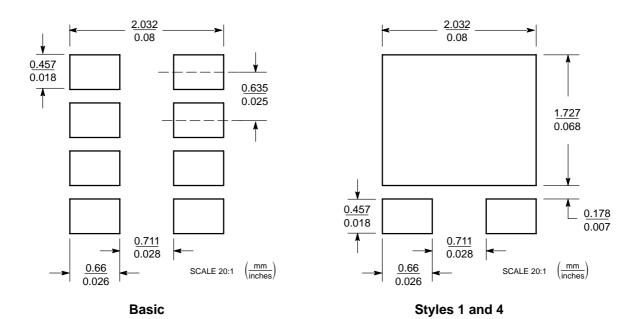
- NOTES:
 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
 NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
q	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.025 BSC			
e1	0.55 BSC			0.022 BSC			
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM			5° NOM			

- STYLE 1: PIN 1. DRAIN 2. DRAIN 4. GATE 5. SOURCE 6. DRAIN 7. DRAIN 8 DRAIN

 - 8. DRAIN





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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